

RF EXPOSURE TEST REPORT

Test Report No. 15407883S-A-R1

Customer	Nintendo Co., Ltd.
Description of EUT	Game Controller
Model Number of EUT	BEE-021
FCC ID	BKEBEE021
Test Regulation	FCC 47CFR 2.1093
Test Result	Complied
Issue Date	January 16, 2025
Remarks	-

	Representative Test Engineer	Approved By
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		ACCREDITED CERTIFICATE 1266.03
╚	The testing in which "Non-accreditation" is displayed is	outside the accreditation scopes in UL Japan, Inc.
⊠ T	There is no testing item of "Non-accreditation".	
	Poport Cover Page Form III	ID_003532 (DCS:13_EM_E0/20) Issue# 2/10 (SAR Povision v/3 13cor2/1000)

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REVISION HISTORY

Original Test Report No.: 15407883S-A

This report is a revised version of 15407883S-A. 15407883S-A is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents														
- (Original)	15407883S-A	November 7, 2024	-														
R1	15407883S-A-R1	, ,		Section 3.1_DSS -> DTS Section 4.2_													
			Antenna Separation distance [mm]														
										3.99	8.84	32.72	36.14	40.04	45.46	52.56	76.5
				Higher			Antenna			Bottom1	Front	Bottom2	Тор	Back	Left	Bottom3	Right
			Tx mode	Freq.		ATP	Gain		RP			est exem					
				[MHz]	[dBm]	[mW]	[dBi]	[dBm]	[mW]	3.0	3.0	udge of S	7.0	206.9	242.5	w) >242.5	>242.5
			EDR	2480	3.5	2	1.52	5.02	3.18	Test	Test	Test					Exempt
			BR,	2480	6.5	4.47	1.52	8.02	6.34	3.0	3.0	3.0	7.0	206.9	242.5	>242.5	>242.5
			BT LE	2.00	0.0		1.02	0.02	0.01	Test	Test	Test	Exempt	Exempt	Exempt	Exempt	Exempt
			->														
											Antenna		on distan				
				i			Antenna			3.99 Bottom1	8.84 Front	32.72 Bottom2	37.36 Top	40.04 Back	45.46 Left	52.56 Bottom3	76.5 Right
				Higher	Max	ATP	Gain	EF	RP	BOILOTTI		est exem	_				Right
			Tx mode	Freq.	[dBm]	[mW]	[dBi]	[dBm]	[mW]			udge of S					
			EDR	2480	3.5	2	1.52	2.87	1.94	6.8 Exempt	8.05 Exempt	97.31 Exempt	125.27 Exempt	142.94 Exempt	182.04 Exempt		490.59 Exempt
			BR, BT LE	2480	6.5	4.47	1.52	5.87	3.86	6.8 Exempt	8.05 Exempt	97.31 Exempt	125.27 Exempt	142.94 Exempt	182.04 Exempt	240.01 Exempt	490.59 Exempt

Reference: Abbreviations (Including words undescribed in this report) (R16v240731S10v240806)

A2LA The American Association for Laboratory Accreditation MRA Mutual Recognition Arrangement AC AFH Alternating Current Adaptive Frequency Hopping MU-MIMO Multi-User Multiple Input Multiple Output (Radio) N/A Not Applicable, Not Applied Amplitude Modulation NII National Information Infrastructure (Radio) AM NIST National Institute of Standards and Technology Amp, AMP **Amplifier** American National Standards Institute **ANSI** NR New Radio Nerve Stimulation Ant, ANT Antenna NS AP Access Point NSA Normalized Site Attenuation APD NVLAP National Voluntary Laboratory Accreditation Program Absorbed Power Density ASK Amplitude Shift Keying OBW Occupied Band Width Atten., ATT Attenuator **OFDM** Orthogonal Frequency Division Multiplexing ΑV **OFDMA** Orthogonal Frequency Division Multiple Access Average **BPSK** Binary Phase-Shift Keying PD Power Density BR Bluetooth Basic Rate psPD Peak spatial-average power density Surface-normal propagation-direction peak spatial-average psPDn+ BT Bluetooth power density BTLE Bluetooth Low Energy psPDtot+ Total propagating spatial-average peak power density Total peak spatial-average power density considering BW BandWidth psPDmod+ reactive near-field effects Cal Int Calibration Interval Power meter P/M Complementary Code Keying Printed Circuit Board CCK PCB CDD Packet Error Rate Cyclic Delay Diversity PER CFR Code of Federal Regulations PHY Physical Layer Ch., CH PΚ Channel Peak CISPR Comite International Special des Perturbations Radioelectriques Pseudo random Noise PΝ CW PP Preamble Puncturing Continuous Wave Differential BPSK **DBPSK** PRBS Pseudo-Random Bit Sequence PSD Power Spectral Density DC Direct Current Quadrature Amplitude Modulation D-factor Distance factor QAM DFS QΡ Dynamic Frequency Selection Quasi-Peak Quadrature Phase Shift Keying DQPSK **QPSK** Differential QPSK DSSS Direct Sequence Spread Spectrum RAT Radio Access Technology **RBW** DUT **Device Under Test** Resolution Band Width FDR Enhanced Data Rate RDS Radio Data System EIRP, e.i.r.p. Equivalent Isotropically Radiated Power RF Radio Equipment RF **EMC** ElectroMagnetic Compatibility Radio Frequency **EMI** ElectroMagnetic Interference RMS Root Mean Square FN European Norm RSS Radio Standards Specifications ERP, e.r.p. Effective Radiated Power RU Resource Unit **ETSI** European Telecommunications Standards Institute Rx Receiving SA, S/A EU European Union Spectrum Analyzer **EUT Equipment Under Test** SAR Specific Absorption Rate Fac. SDM Space Division Multiplexing FCC Federal Communications Commission SISO Single Input Single Output (Radio) **FHSS** Frequency Hopping Spread Spectrum SG Signal Generator FΜ Frequency Modulation sPD Spatial-average power density Surface-normal propagation-direction spatial-average Frea. Frequency sPDn+ power density **FSK** Frequency Shift Keying sPDtot+ . Total propagating spatial-average power density Total spatial-average power density considering reactive **GFSK** sPDmod+ Gaussian Frequency-Shift Keying near-field effects **GNSS** Global Navigation Satellite System SPI SR SAR to Peak Location Separation Ratio **GPS** Global Positioning System **SVSWR** Site-Voltage Standing Wave Ratio ΗE High Efficiency (e.g. IEEE 802.11ax20HE) TER Total Exposure Ratio HT High Throughput (e.g. IEEE 802.11n20HT) **TSL** Tissue Simulation Liquid Test Receiver Hori. Horizontal T/R Interference-Causing Equipment Standard **ICES** Tx Transmitting

IEC International Electrotechnical Commission Institute of Electrical and Electronics Engineers **IEEE**

Intermediate Frequency

ILAC International Laboratory Accreditation Conference

IPD Incident Power Density

ISED Innovation, Science and Economic Development Canada

International Organization for Standardization ISO

Japan Accreditation Board JAB LAN Local Area Network

LIMS Laboratory Information Management System

MCS Modulation and Coding Scheme Multiple Input Multiple Output (Radio) MIMO **MPE** Maximum Permissible Exposure

U-NII Unlicensed National Information Infrastructure (Radio)

URS Unintentional Radiator(s) Video BandWidth

VBW Vert. Vertical

Very High Throughput (e.g. IEEE 802.11ac20VHT) VHT

Wireless LAN WLAN

Wireless LAN, trademarked by Wi-Fi Alliance Wi-Fi, WiFi

Wireless Power Transmit

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SECTION 1: Customer information

Company Name	Nintendo Co., Ltd.
Address	11-1 Hokotate-cho, Kamitoba, Minami-ku, Kyoto 601-8501, Japan
Telephone Number	+81-75-662-9600
Contact Person	Yosuke Ishikawa

The information provided from the customer is as follows;

- Customer name, Company name, Type of Equipment, Model No., FCC ID on the cover and other relevant pages.
- SECTION 1: Customer information
- SECTION 2: Equipment under test (EUT) SECTION 4: Operation of EUT during testing
- Appendix 1: The part of Antenna location information, Description of EUT and Support Equipment

SECTION 2: Equipment under test (EUT)

Identification of EUT

Туре	Game Controller			
Model Number	BEE-021			
Serial Number	HHL04000006178			
Rating	DC 5 V (*.Supply voltage from connector) (*. DC 3.89 V from Re-chargeable Li-ion battery for the internal circuit)			
Condition of sample	e Engineering prototype (Not for sale: The sample is equivalent to mass-produced items.)			
Receipt Date of sample	October 9, 2024 (for power measurement) (*. No modification by the Lab.)			
Receipt Date of Sample	October 23, 2024(for SAR test) (*. No modification by the Lab.)			
Test Date (SAR)	October 24, 2024			

Product Description

This report contains data provided by the customer which can impact the validity of results. UL Japan, Inc. is only responsible for the validity of results after the integration of the data provided by the customer. The data provided by the customer is marked "a)" in the table below.

General

	
Feature of EUT	Model: BEE-021 (referred to as the EUT in this report) is a Game Controller.
SAR Category	Portable device (*. Since EUT may contact to a localized human body during wireless operation, the partial-
Identified	body SAR (1g) shall be observed.)
SAR Accessory	None, there are no accessories that would affect SAR test.

Radio specification

Equipment type	Transceiv	Transceiver										
Frequency of operation	Bluetooth:	Bluetooth: 2402 MHz ~ 2480 MHz										
Supported modulations	Bluetooth:	Bluetooth: BR/EDR/BT LE (FHSS, GFSK (*. EDR: GFSK+ \(\pi \)4-DQPSK, GFSK+ 8DPSK))										
Typical and maximum transmit power	*. The specification of typical and maximum transmit power (which may occur) refer to remarks in below "Table of power and Maximum tune-up tolerance limit power". The measured output power (conducted) as SAR reference refers to section 5 in this report.											
Antenna quantity	1 pc.	Antenna type	PCB antenna	Antenna connector type	PCB integrated							
Antenna gain a)	1.52 dBi (max. gain)											

Table of Typical power and Maximum tune-up tolerance limit power (*. Indicate only the lowest data rate which has maximum power.) Maximum tune-up tolerance limit is conducted burst average power and is defined by a customer as Duty cycle 100% (continuous transmitting).

Type Band		Channel		Frequency	Mode	D/R	Тур.	Max.
Type	Danu	Channe		[MHz]	Wiode	[Mbps]	[dBm]	[dBm]
BT	BR	0 to 7	78	2402 to 2480	DH5	1	-	6.5
BT	EDR	0 to 7	78	2402 to 2480	2DH5	2	-	3.5
BT	EDR	0 to 7	78	2402 to 2480	3DH5	3	-	3.5
BT	BTLE	0 to 3	39	2402 to 2480	PHY1	1	-	6.5
BT	BTLE	0 to 3	39	2402 to 2480	PHY2	2	-	6.5

[:] The transmission mode with the highest power in each band is marked with a yellow marker.

D/R: data rate, Ant.: antenna, Max. Maximum tune-up limit power, N/A: Not applicable

SECTION 3: Maximum SAR value, test specification and procedures

3.1 **Summary of Maximum SAR Value**

		Highest Reported SAR [W/kg]							
Mode / E	Band	SAR type	Partial-body (Flat phantom, Separation 0 mm)	SAR type	1 1044	SAR type	Limbs (Flat phantom)		
FHSS) Blu	ıotooth	1g	(Fiat priantorn, Separation (Finite) < 0.10		N/A	10g	N/A		
rnoo) bil	JELOOLIT	ıg	~ 0.10	1g	IN/A	iug	IV/A		
DTS) Bluetooth		1g	< 0.10	1g	N/A	10g	N/A		
			N/A	1g	N/A	10g	N/A		
			6 W/kg (SAR1g) for general population/	unco	ntrolled exposure is specified in FCC	47 C	FR 2.1093.		
Test	Refer to S	ectio	n 3.2 in this report. In addition;						
Procedure	UL Japan	's SA	R measurement work procedures No. 1	JLID-	003599 (13-EM-W0430).				
riocedule	UL Japan	's SA	R measurement equipment calibration a	and ir	nspection work procedurés No. ULID	-0035	598 (13-EM-W0429).		

Conclusion

The SAR test values found for the device are separately below the maximum limit of 1.6 W/kg.

3.2 **RF Exposure limit**

SAR Exposure Limit (100 kHz ~ 6 GHz)									
General Population / Uncontrolled Exposure (*1) Occupational / Controlled Exposure (*)									
Spatial Peak SAR (*3) (Whole Body)	0.08 W/kg	0.4 W/kg							
Spatial Peak SAR (*4) (Partial-Body, Head or Body)	1.6 W/kg	8 W/kg							
Spatial Peak SAR (*5) (Hands / Feet / Ankle / Wrist)	4 W/kg	20 W/kg							

- For the purpose of this Regulation, FCC has adopted the SAR and RF exposure limits established in FCC 47 CFR 1.1310: Radiofrequency radiation exposure limits. General Population / Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure.
- Occupational / Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation).

- The Spatial Average value of the SAR averaged over the whole body.

 The Spatial Average value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

 The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

The limit applied to this device which tested in this report is;

Limit of Spatial Peak SAR (Partial-Body)	1.6 W/ka	General population / uncontrolled expos	
I I Imit of Spatial Peak SAR (Partial-Book)	1 h vv/ka	Caeneral nonlilation / Lincontrolled expos	J I I P
Entite of opation Fount of the first body	I.O VV/NG	Ochiciai populationi, ancontrolica expos	uic

3.3 **Test specification**

Standard	Description	Version									
47 CFR 2.1093	(Limit) Radiofrequency radiation exposure evaluation: portable devices										
ANSI/IEEE C95.1	IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 KHz to 300 GHz	1992									
IEEE Std. 1528	IEEE Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques.	2013									
KDB 248227 D01	SAR Guidance for IEEE 802.11 (Wi-Fi) transmitters v02r02	v02r02									
KDB 447498 D04	Interim General RF Exposure Guidance v01	v01									
KDB 447498 D03	OET Bulletin 65, Supplement C Cross-Reference v01	v01									
KDB 865664 D01	SAR measurement 100 MHz to 6 GHz v01r04	v01r04									
KDB 865664 D02	RF exposure compliance reporting and documentation considerations v01r02	v01r02									
IEC/IEEE 62209-1528 (*1)	Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices – Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz) Secs. 6.1, 7.4.2, 7.7 - fabove 4 MHz SAR provisions (TCB workshop, 2022-10)										

^{*1.} The measurement uncertainty budget is suggested by IEC/IEEE 62209-1528:2020. Refer to Appendix3-3 for more details.

In addition to the above, the following information was used:

	(RF Exposure Procedure) Bluetooth Duty Factor.
	(RF Exposure Procedure) DUT Holder Perturbations; When the highest reported SAR of an antenna is > 1.2 W/kg, holder perturbation verification is
1CB Workshop 2010-10	required for each antenna, using the highest SAR configuration among all applicable frequency bands.
TCB workshop 2017-05	(RF Exposure Procedure) Broadband liquid above 3 GHz. Allow application of 10% tissue dielectric tolerance correction in KDB 865664 D01.
TCB workshop 2018-04	(RF Exposure Procedure) Allow Expedited Area Scans. (including mother scans)
	(RF Exposure Procedure) 802.11ax SAR Testing
	(RF Exposure Procedure) Tissue Simulating Liquids (TSL) FCC has permitted the use of single head tissue simulating liquid specified in IEC 62209
1CB Workshop 2019-04	for all SAR tests. If FCC parameters are used, 5 % tolerance. If IEC parameters, 10 %.
TCB workshop 2019-04	(RF Exposure Policy) SAR Zoom-Scan Update.
TCB workshop 2021-04	(RF Exposure Procedure) Application of specific phantoms. (case by case, PAG)

3.4 Addition, deviation and exclusion to the test procedure

No addition, exclusion nor deviation has been made from the test procedure.

Test Location

UL Japan, Inc., Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 JAPAN

Telephone number: +81 463 50 6400

*. A2LA Certificate Number: 1266.03 (FCC Test Firm Registration Number: 626366, ISED Lab Company Number: 2973D / CAB identifier: JP0001)

Place	Width \times Depth \times Height (m)	Size of reference ground plane (m) / horizontal conducting plane
No.7 Shielded room	2.76 × 3.76 × 2.4	2.76 × 3.76

3.6 SAR measurement procedure

3.6.1 SAR Definition

SAR is defined as the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ). The equation description is shown in right.	$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho * dV} \right)$
SAR measurement can be related to the electrical field in the tissue by the equation in right. SAR is expressed in units of Watts per kilogram (W/kg).	$SAR = \frac{\sigma E ^2}{}$
Where : σ = conductivity of the tissue (S/m), ρ = mass density of the tissue (kg/m³), E = RMS electric field strength in tissue (V/m)	ρ

3.6.2 Full SAR measurement procedure

The SAR measurement procedures are as follows: (1) The EUT is installed engineering testing software that provides continuous transmitting signal; (2) Measure output power through RF cable and power meter; (3) Set scan area, grid size and other setting on the DASY software; (4) Find out the largest SAR result on these testing positions of each band; (5) Measure SAR results for other channels in worst SAR testing position if the SAR of highest power channel is larger than 0.8 W/kg.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps: Step 1) Power measurement -> SAR: Step 2) Power reference measurement -> Step 3) Area scan -> Step 4) Zoom scan -> Step 5) Power drift measurement

Step 1: Confirmation before SAR testing

Before SAR test, the RF wiring for the sample had been switched to the antenna conducted power measurement line from the antenna line and the average power was measured. This SAR reference power measurement was proceeded with the lowest data rate (which may have the higher time-based average power typically) on each operation mode and on the lower, middle (or near middle), upper and specified channels. The power measurement result is shown in Section 5.

The EUT transmission power used SAR test was verified that it was not more than 2 dB lower than the maximum tune-up tolerance limit. (KDB447498 D04 (v01))

Step 2: Power reference measurement

Measured psSAR value at a peak location of Fast Area Scan was used as a reference value for assessing the power drop.

Step 3: Area Scan

(Scan parameters: KDB 865664 D01, IEC/IEEE 62209-1528 (> 6GHz)) Area Scans are used to determine the peak location of the measured field before doing a finer measurement around the hotspot. Peak location can be found accurately even on coarse grids using the advanced interpolation routines implemented in DASY8. Area Scans measure a two dimensional volume covering the full device under test area. DASY8 uses Fast Averaged SAR algorithm to compute the 1 g and 10 g of simulated tissue from the Area Scan. DASY8 can either manually or automatically generates Area Scan grid settings based on

device dimensions. In automatically case, the scan extent is defined by the device dimensions plus additional 15mm on each side. In manually, the scan covered the entire dimension of the antenna of FUT

Step 4: Zoom Scan and post-processing (Scan parameters: KDB 865664 D01, IEC/IEEE 62209-1528 (> 6GHz))

Zoom Scans are used to assess the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The Zoom Scan measures points (refer to table below) within a cube whose base faces are centered on the maxima found in a preceding area scan job within the same procedure.

- * A minimum volume of 30 mm (x) × 30 mm (y) × 30 mm (z) was assessed by "Ratio step" method (*1), for 2.4 GHz band. (Step XY: 5 mm)
 * A minimum volume of 24 mm (x) × 24 mm (y) × 24 mm (z) was assessed by "Ratio step" method (*1), for 5 GHz band (Step XY: 4 mm).
 * A minimum volume of 24 mm (x) × 24 mm (y) × 24 mm (z) was assessed by "Ratio step" method (*1), for 6 GHz band (Step XY: 34 mm).
 * A minimum volume of 24 mm (x) × 24 mm (y) × 24 mm (z) was assessed by "Ratio step" method (*1), for 6 GHz band (Step XY: 3.4 mm).

When the SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are proceeded for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR. If the zoom scan measured as defined above complies with both of the following criteria. or if the peak spatial-average SAR is below 0.1 W/kg, no additional measurements are needed.

- The smallest horizontal distance from the local SAR peaks to all points 3

 Std 1528-2013 (≤ 6 GHz) and IEC/IEEE 62209-1528 (≤ 10 GHz) for details.

 SAR peaks shall be larger than the horizontal grid steps in 1. When zoom scan is required and the reported SAR from the area scan based 1-g SAR. dB below the SAR peak shall be larger than the horizontal grid steps in both x and y directions and recorded.
- The ratio of the SAR at the second measured point to the SAR at the closest measured point at the x-y location of the measured maximum SAR value shall be at least 30 % and recorded.

ATTIOIC GIAITZ	- GD 10W		num une-up tolerance iimit	·
Mandan nee el	intono-	franc alasast	f≤3 GHz	3 GHz < <i>f</i> ≤ 10 GHz
measurement center of prophantom su	ent point obe sens		5 mm ± 1 mm	$\begin{array}{c} 1/2 \times \delta \times \ln(2) \text{mm} \\ \pm 0.5 \text{mm} \end{array}$
	tom sur	gle from probe face normal at ocation	$5^{\circ}\!\pm\!1^{\circ}\!(\text{flat phantom only})$ $30^{\circ}\!\pm\!1^{\circ}\!(\text{other phantom})$	$5^{\circ}\pm1^{\circ}$ (flat phantom only) $30^{\circ}\pm1^{\circ}$ (other phantom)
Maximum a			≤2 GHz:≤15 mm, 2~3 GHz:≤12 mm	3~4 GHz : ≤ 12 mm, 4~6 GHz : ≤ 10 mm > 6 GHz : ≤ 60/f mm, or half of the corresponding zoom scan length, whichever is smaller.
resolution.		sy Area	When the x or y dimension o measurement plane orientati above, the measurement rescorresponding x or y dimensi least one measurement poin	on, is smaller than the colution must be ≤ the ion of the test device with at
Maximum z resolution: Δ			\leq 2 GHz : \leq 8 mm, 2~3 GHz : \leq 5 mm (*1)	3~4 GHz:≤5 mm (*1), 4~6 GHz:≤4 mm (*1) >6 GHz:≤24/f mm
Maximum zoom scan	uniform	n grid: Δz _{zcom} (n)	≤5mm	3~4 GHz:≤4 mm, 4~5 GHz:≤3 mm, 5~6 GHz:≤2 mm >6 GHz:≤10/(£1) mm
spatial resolution, normal to phantom	graded	Δz _{zom} (1): between 1st two points closest to phantom surface	≤4 mm	3~4 GHz:≤3 mm, 4~5 GHz:≤2.5 mm, 5~6 GHz:≤2 mm >6 GHz:≤12/f mm
surface	grid	Δz _{Zcom} (n>1): between subsequent points	≤ 1.5 × Δz ₂₀	_{om} (n-1) mm
Minimum zoom scan volume			≥30 mm	3~4 GHz:≥28 mm, 4~5 GHz:≥25 mm, 5~6 GHz:≥22 mm >6 GHz:≥22 mm
Note: δ is the Std 1528-20	penetrat 13 (< 6 G	ion depth of a pland iHz) and IEC/IEEE	e-wave at normal incidence to	the tissue medium; see IEEE

estimation procedures of KDB Publication 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz. (KDB 865664 D01)
*. The scan parameters of > 6GHz is defined IEC/IEEE 62209-1528.

Step 5: Power drift measurement

The Power Drift Measurement measures the field at the same location as the most recent power reference measurement within the same project. The Power Drift Measurement gives the SAR difference in dB from the reading conducted within the last Power Reference Measurement. This allows a user to monitor the power drift of the device under test within a batch process. It was checked that the power drift was within ± 5% (0.21 dB) in single SAR project run. The verification of power drift during the SAR test shown in SAR plot data of APPENDIX 2.

The most of SAR tests were conservatively performed with test separation distance 0 mm. The phantom bottom thickness is approx. 2mm. Therefore, the distance between the SAR probe tip to the surface of test device which is touched the bottom surface of the phantom is approx. 2.4 mm. Typical distance from probe tip to probe's dipole centers is 1mm

[&]quot;Ratio step" method parameters used; the first measurement point: "1.4 mm" from the phantom surface, the initial z grid separation: "1.5 mm", subsequent graded grid ratio: "1.5" for 2.4 GHz band and the initial z grid separation: "1.4 mm", subsequent graded grid ratio: "1.4" for above 5 GHz. These parameters comply with the requirement of KDB 865664 D01and recommended by Schmid & Partner Engineering AG (DASY8 manual).

Operation of EUT during testing SECTION 4:

4.1 Operating modes for testing

The EUT has Bluetooth continuous transmitting modes.

The test modes and frequencies used in the SAR test are shown in the table of power measurement results in Section 5 with markings. The control software in the power measurement and SAR test are shown in the following.

Controlled	Test name	Software name	Version	Date	Storage location / Remarks
software	Power measurement	InspectionFwPackage	V1.0.14	2024-09-18	*. Memory of EUT (firmware), set by host PC.
Soliware	SAR test	InspectionFwPackage	V1.0.14	2024-09-18	*. Memory of EUT (firmware), set by host PC.

4.2 RF exposure conditions (Test exemption)

Antenna separation distances in each test setup plan are shown as follows.

SAR test exemption consideration by KDB 447498 D04 (v01)

-					-		Antenna Separation distance [mm]									
							3.99	8.84	32.72	37.36	40.04	45.46	52.56	76.5		
Antenna							Bottom1	Front	Bottom2	Тор	Back	Left	Bottom3	Right		
Tx mode	Higher Freq.	Max.	ATP	Gain	EF	RP	SAR1g test exempt threshold power [mW] (upper row)									
1X IIIOGE	[MHz]	[dBm]	[mW]	[dBi]	[dBm]	[mW]		Jı	udge of S	SAR test exemption (lower row)						
EDR	2480	3.5	2	1.52	2.87	1.94	6.8	8.05	97.31	125.27	142.94	182.04	240.01	490.59		
LDIX	2400	5.5	2	1.02	2.07	1.54	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt		
BR,	2480	6.5	4.47	1.52	5.87	3.86	6.8	8.05	97.31	125.27	142.94	182.04	240.01	490.59		
BT LE	2-100	0.0	7.41	1.02	5.07	0.00	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt	Exempt		

Freq.: Frequency, ATP: Antenna terminal conducted power

- Bottom1 was judged SAR test exempt with a SAR of 10g because the gap was small and only a finger could fit through.

 Antenna separation distance. It is the distance from the antenna inside EUT to the outer surface of EUT which user may touch. Details of "antenna separation" distance" and "Size of EUT" are shown in Appendix 1-1.
- The table shows the upper frequency which has the maximum power (as "Tune-up limit") in each operation band, in mode and on the single antenna transmission. The actual test setup tested depends on the measurement results. See Section 7 for the actual tested test setup.

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Table B1—Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Table B1—Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Threshold ERF |

 Table B1—Thresholds For Single RF Source Frequency | Minimum Distance | Thresholds For Single RF Source Frequency | Thresholds For Single Since this method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive), when the minimum test separation distance is < 5 mm, a distance of 5 mm was applied to determine SAR test exclusion for the calculation.

 $\dot{\text{ERP}}$ (dBm) = (Max. ATP, dBm) + (antenna gain, dBi) – 2.15 2) SAR test exempt threshold power $P_{th}(mW)$ = $(2040f \ 0.3 \ GHz \le f < 1.5 \ GHz$ $ERP_{20cm}(mW) =$ $3060 ~~1.5~GHz~\leq f \leq 6.0~GHz$

 $P_{th}(mW) =$ $20cm < d \le 40cm$ where $x = -log_{10} \left(\frac{1}{ERP_{20cm} \sqrt{f}} \right)$ 60

and f is in GHz, d is the separation distance (cm), and ERP20cm is per Formula (B.1).

Threshold ERP $\frac{\lambda_L/2 \,\pi}{159 \,\mathrm{m}}$ - $\lambda_H/2\pi$ 35.6 m 1920 R 35.6 m 1.6 m 159 mm 1.6 m 159 m $\frac{1920 \ R^2/f^2}{3.83 \ R^2}$ 1.34 $0.0128 R^2 f$ - 31.8 mm 1500 - 100000 31.8 mm - 0.5 mm

Subscripts L and H are low and high; \(\lambda\) is wavelength.
From § 1.1307(b)(3)()(C), modified by adding Minimum Distance
oolumns. R is in meter, if is in MHz.
Upper 2.4GHz; Threshold ERP [W] = 19.2 × R*2, at distance; over 40 cm

SAR-based thresholds (Pth (mW) shown below table of "Example Power Thresholds [mW]" are derived based on frequency, power, and separation distance of the RF source. The formula defines the thresholds in general for either available maximum time-averaged power or maximum time-averaged effective radiated power (ERP), whichever is greater. The SAR-based exemption is calculated by Formula (B.2) in below, applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power or effective When 10-g extremity SAR applies, SAR test exemption may be considered by applying a factor of 2.5 to the SAR-based exemption thresholds.

This method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive).

Below is the test reduction procedure for KDB.

* OFDM Transmission Mode SAR Test Configuration and Channel Selection Requirements
(KOB 248227 D01, SAR Guidance for Wi-Fi Transmitters) The initial test configuration for 2.4 GHz and 5 GHz OFDM transmission modes is determined by the 802.11 configuration with the highest maximum output power specified for production units, including tune-up tolerance, in each standalone and aggregated frequency band. SAR for the initial test configuration is measured using the highest maximum output power channel determined by the default power measurement procedures.

When multiple channel bandwidth configurations in a frequency band have the same specified maximum output power, largest channel bandwidth, lowest order modulation and levest order 802.11 mode is selected.

lowest data rate, the lowest order 802.11 mode is selected.

*. SAR test reduction considerations (KDB 447498 D04(v01), General RF Exposure Guidance) Testing of other required channels within the operating mode of a frequency band is not required when the reported 1g or

10g SAR for the mìd-band or highest output power channel is: (1) ≤ 0.8 W/kg for 1g , or 2.0 W/kg for 10g respectively, when the transmission band is≤ 100 MHz

(1) ≤ 0.6 W/kg for 1g, or 2.5 V/kg for 10g respectively, when the transmission band is 5 ≥ 100 W/Lz

≤ 0.6 W/kg for 1g, or 1.5 W/kg for 10g respectively, when the transmission band is between 100 MHz and 200 MHz

(3) ≤ 0.4 W/kg for 1g, or 1.0 W/kg for 10g respectively, when the transmission band is ≥ 200 MHz

The SAR has been measured with highest transmission duty factor supported by the test mode tool for WLAN and/or Bluetooth. When the transmission duty factor could not be 100%, the reported SAR will be scaled to 100% transmission duty factor to determine compliance. When SAR is not measured at the maximum power level allowed for production unit, the measured SAR will be scaled to the maximum tune-up tolerance limit to determine compliance.

(KDB 248227 D01, SAR Guidance for Wi-Fi Transmitters) When the reported SAR of the initial test configuration is > 0.8 W/kg, SAR measurement is required for subsequent next highest measured output power channel(s) in the initial test configuration until reported SAR is ≤ 1.2 W/kg or all required channels are tested.

For 2.4GHz band, the highest measured maximum output power channel of DSSS was selected for SAR measurement, When the reported SAR is ≤ 0.8 W/kg, no further SAR test is required in this exposure configuration. Otherwise, SAR is required for that exposure configuration using the next highest measured output power channel. When any reported SAR is > 1.2 W/kg, SAR is required for the third channel. For OFDM modes (802.11g/n), SAR is not required when the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2 W/kg.

SECTION 5: Confirmation before testing

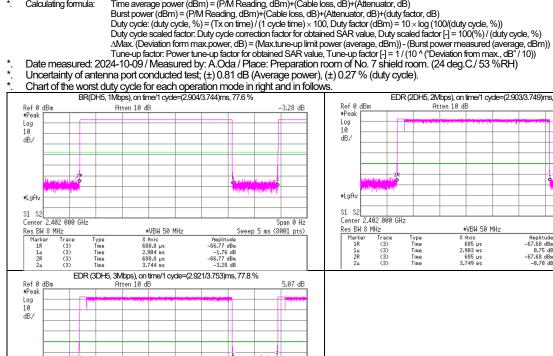
5.1 Test reference power measurement

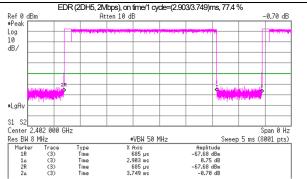
		Tx mo	de		Power		Duty	Duty	Duty		Po	wer		Adjusted
СН	Freq.	Mode	D/R	Тур.	Max.	Set	cycle	factor	scaled factor	Burst Ave.	Δmax	Scaled Factor	Time. Ave	power setting?
	[MHz]		[Mbps]	[dBm]	[dBm]		[%]	[dB]	[-]	[dBm]	[dB]	1 actor	[dBm]	(*1)
0	2402	BR	1	-	6.5	fix	77.6	1.10	1.29	5.10	1.40	1.38	4.00	No
39	2441	BR	1	-	6.5	fix	77.6	1.10	1.29	5.13	1.37	1.37	4.03	No
78	2480	BR	1	-	6.5	fix	77.6	1.10	1.29	5.25	1.25	1.33	4.15	No
0	2402	EDR(2M)	2	-	3.5	fix	77.4	1.11	1.29	1.92	1.58	1.44	0.81	No
39	2441	EDR(2M)	2	-	3.5	fix	77.4	1.11	1.29	1.97	1.53	1.42	0.86	No
78	2480	EDR(2M)	2	-	3.5	fix	77.4	1.11	1.29	2.15	1.35	1.36	1.04	No
0	2402	EDR(3M)	3	-	3.5	fix	77.8	1.09	1.29	1.90	1.60	1.45	0.81	No
39	2441	EDR(3M)	3	-	3.5	fix	77.8	1.09	1.29	1.95	1.55	1.43	0.86	No
78	2480	EDR(3M)	3	-	3.5	fix	77.8	1.09	1.29	2.11	1.39	1.38	1.02	No
0	2402	BT LE(1M)	1	-	6.5	fix	86.3	0.64	1.16	5.07	1.43	1.39	4.43	No
19	2440	BT LE(1M)	1	-	6.5	fix	86.3	0.64	1.16	4.92	1.58	1.44	4.28	No
39	2480	BT LE(1M)	1	-	6.5	fix	86.3	0.64	1.16	5.20	1.30	1.35	4.56	No
0	2402	BT LE(2M)	2	-	6.5	fix	58.7	2.31	1.70	5.00	1.50	1.41	2.69	No
19	2440	BT LE(2M)	2	-	6.5	fix	58.7	2.31	1.70	4.85	1.65	1.46	2.54	No
39	2480	BT LE(2M)	2	•	6.5	fix	58.7	2.31	1.70	5.14	1.36	1.37	2.83	No

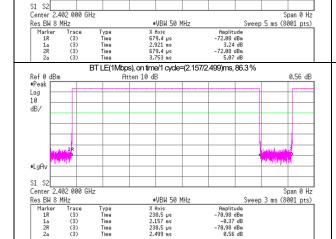
: SAR test was applied.

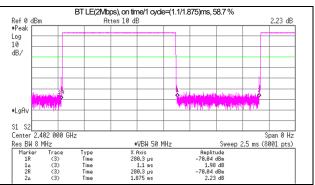
#LgAv

- "Yes": The power setting was adjusted so that measured average power was not more than 2 dB lower than the maximum tune-up tolerance limit. CH: Channel; Power: Power specification; Max.: Maximum; Set. Set power by test software; Burst Ave.: Measured burst average power; Time Ave.: Measured time-based average power; N/A: Not applied,/Not applicable
- Time average power (dBm) = (P/M Reading, dBm)+(Cable loss, dB)+(Attenuator, dB) Calculating formula:









SECTION 6: Tissue simulating liquid

6.1 Liquid measurement

<SPC: System performance check>

Date	Frea.	Lia.	Target	get Permittivity (*.measured)					Target	Conductivity (*.measured)			ΔSAR			e',e"	Liq.	Liq.	Limidonana	
measured	i icq.	tv pe	e'	e'	Δe'	Limit	е"	Δend	σ_tgt	σ	Δσ	Limit	Δend	1g	10g	correct	Lerp	Temp.	depth	Liquid usage conditions
(YYYY-MM-DD)	[MHz]	ty pe	[-]	[-]	[%]	[%](*2)	[-]	[%](*1)	[S/m]	[S/m]	[%]	[%](*2)	[%](*1)	[%]	[%]	?	?	[deg.C.]	[mm]	CONGREGIS
2024-10-23	2450	Head	39.20	39.68	1.2	±10	13.6656	<48 hrs	1.800	1.863	3.5	±10	<48 hrs	1.4	0.7	No	No	22.2	150	<48 hrs
ZCAD toots																				

SAR test?

Date	te Freg. Lig. Target Permittivity (*.measured)					Target	Conductivity (*.calculated)(*4)				DOAIL			e',e"	Liq.	Liq.	Liquid usage			
measured	1 104.	ty pe	e'	e'	Δe'	Limit	е"	Δend	σ_tgt	σ	Δσ	Limit	Δend	1g	10g	required	Lerp	Temp.	depth	conditions
(YYYY-MM-DD)	[MHz]	ty pc	[-]	[-]	[%]	[%](*2)	[-]	[%](*1)	[S/m]	[S/m]	[%]	[%](*2)	[%](*1)	[%]	[%]	required ?	?	[deg.C.]	[mm]	(*1)
2024-10-23	2402	Head	39.29	39.77	1.2	±10	13.6465	<48hrs.	1.757	1.824	3.8	±10	<48hrs.	1.6	0.8	No	No	22.2	150	Measured before SAR
2024-10-23	2440	Head	39.22	39.70	1.2	±10	13.6586	<48hrs.	1.791	1.854	3.5	±10	<48hrs.	1.4	0.7	No	No	22.2	150	test. There were used
2024-10-23	2441	Head	39.22	39.69	1.2	±10	13.6593	<48hrs.	1.792	1.855	3.5	±10	<48hrs.	1.4	0.7	No	No	22.2		until 2024-10-24 (< 48
2024-10-23	2480	Head	39.16	39.63	1.2	±10	13.6889	<48hrs.	1.833	1.889	3.1	±10	<48hrs.	1.2	0.6	No	No	22.2	150	hrs.).

Lerp: Linear interpolation, Ref.: reference

"Dend (when, >48 hrs.) (%)"" = {(dielectric properties, end of test series) / (dielectric properties, beginning of test series) -1} × 100 The electrical properties of the liquid at <6 GHz were controlled to within 5% even with a limit of 10%

The target values refers to clause 6.2 of this report.

The coefficients in below are parameters defined in IEEE Std.1528. $(Calculating \ formula, 4 \ MHz \sim 6 \ GHz): \ \Delta SAR(1g) = C \epsilon r \times \Delta \epsilon r + C \sigma \times \Delta \sigma, \ Ce=-7.854E + 4 \% + 9.402E + 3 \% + 2.742E + 2.402026 / C\sigma = 9.804E + 3 \% + 8.661E + 2.4\% + 2.981E + 2.4\% + 0.7829 + 2.4\% + 9.402E + 3.4\% + 9.402E + 9.4\% + 9$ $\Delta SAR(10g) = C \text{cr} \times \Delta \text{cr} + C_{\sigma} \times \Delta \sigma, \text{ } C_{\text{cr}} = 3.456 \times 10^{3} \text{d}^{3} \cdot 3.531 \times 10^{2} \text{d}^{2} + 7.675 \times 10^{2} \times 10.1860 / \text{C}_{\sigma} = 4.479 \times 10^{3} \text{d}^{3} \cdot 1.586 \times 10^{2} \text{d}^{2} \cdot 0.1972 \times 10.7717}$ Since the ΔSAR values of the tested liquid had shown positive, the measured SAR was not ΔSAR corrected by the conservative reason. (Calculating formula): \triangle SAR corrected SAR (W/kg) = (Measured SAR (W/kg)) × (100 - (\triangle SAR(%)) / 100

Target of tissue simulating liquid

Nominal dielectric values of the tissue simulating liquids in the phantom are listed in the following table. (Appendix A, KDB 865664 v01r04)

Target Frequency	He	ead	Body		Body		Body		Body		Target Frequency	He	ead	В	lody
(MHz)	ε _r	σ(S/m)	ε _r	σ(S/m)	(MHz)	ε _r	σ(S/m)	ϵ_{r}	σ(S/m)						
1800~2000	40.0	1.40	53.3	1.52	3000	38.5	2.40	52.0	2.73						
2450	39.2	1.80	52.7	1.95	5800	35.3	5.27	48.2	6.00						

For other frequencies, the target nominal dielectric values were obtained by linear interpolation between the higher and lower tabulated figures. Above 5800MHz were obtained using linear extrapolation.

6.3 Simulated tissue composition

Liquid type	Head	Control No.	SSLHV6-01	Model No. / Product No.	HBBL600-10000V6 / SL AAH U16 BC							
Ingredient: Mixture [%]	Water: >77, Ethanediol: <5.2, Sodium petroleum sulfonate: <2.9, Hexylene Glycol: <2.9, alkoxylated alcohol (>C ₁₆): <2.0											
Tolerance specification		± 10%										
Temperature gradients [% / deg.C]		permittivity: -0.19 / conductivity: -0.57 (at 2.6 GHz), permittivity: +0.31 / conductivity: -1.43 (at 5.5 GHz) (*)										
Manufacture	Schmid &	Partner Engineer	ng AG No	ote: *. speag_920-SLAAxyy-E_1.12.15	5CL (Maintenance of tissue simulating liquid)							

Definition of Δend.) "begin": there are measured before SAR test; "< 24 hrs.": SAR test has ended within 24 hours from the liquid parameter measured; "< 48 hrs.": Since SAR test has ended within 48 hours from the liquid parameter measured and a change in the liquid temperature was within 1 degree, liquid parameters measured on first day were used on next day continuously; "> 48 hrs.": Since the SAR test series took longer than 48 hours, the liquid parameters were measured on every 48 hours period and on the date which was end of test series. Since the difference of liquid parameters between the beginning and next measurement was smaller than 5%, the liquid parameters measured in beginning were used until end of each test series.

Calculating formula: "Δend (when, >48 hrs.) (%)"" = {(dielectric properties, end of test series) / (dielectric

The electrical characteristics of the SAR test frequencies were measured using DAK software, DAK-3.5 and a network analyzer with the 2.4 GHz band swept at 1 MHz and the 5 GHz and 6 GHz bands swept at 5 MHz. In this way, the electrical characteristics of all test frequencies were measured directly at the individual frequencies without interpolation.

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SECTION 7: Measurement results

Measurement results 7.1

7.1.1 SAR measurement results

RF Exposure	Setup	Gap	Source	T	mod	le		Fred	q .	Duty	Duty S/F	Pmax	Pset	Pmeas	Pwr. S/F	SAR	1g [W/kg] (*b)	Limit	SAR1	10g [W/k	g] (*b)	Limit	Data	Setup
conditon	position	[mm]	power	mode	Tx	Stream	D/R [Mbps]	[MHz]	СН	[%]	[-]	[dBm]	[-]	[dBm]	[-]	Meas.	Δsar(*a)	Report	[W/kg]	Meas.	Δsar(*a)	Report	[W/kg]	plot#, Appx.2	photo#, Appx.1-3
Body	Front	0	Battery	BR	1Tx	•	1	2402	0	77.6	1.29	6.5	fix	5.1	1.38	0.013	N/A	0.023	1.6	0.007	N/A	0.012	N/A	-	S1
Body	Front	0	Battery	BR	1Tx		1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.013	N/A	0.023	1.6	0.007	N/A	0.012	N/A	-	S1
Body	Front	0	Battery	BR	1Tx	•	1	2480	78	77.6	1.29	6.5	fix	5.25	1.33	0.015	N/A	0.026	1.6	0.008	N/A	0.014	N/A	D2	S1
Body	Front	0	Battery	BT LE(1M)	1Tx	•	1	2402	0	86.3	1.16	6.5	fix	5.07	1.39	0.013	N/A	0.021	1.6	0.007	N/A	0.011	N/A	-	S1
Body	Front	0	Battery	BT LE(1M)	1Tx	•	1	2440	19	86.3	1.16	6.5	fix	4.92	1.44	0.014	N/A	0.023	1.6	0.008	N/A	0.013	N/A	-	S1
Body	Front	0	Battery	BT LE(1M)	1Tx		1	2480	39	86.3	1.16	6.5	fix	5.2	1.35	0.018	N/A	0.028	1.6	0.01	N/A	0.016	N/A	D1	S1
Body	Front	0	Battery	BT LE(2M)	1Tx		2	2402	0	58.7	1.7	6.5	fix	5	1.41	0.008	N/A	0.019	1.6	0.004	N/A	0.01	N/A	-	S1
Body	Front	0	Battery	BT LE(2M)	1Tx		2	2440	19	58.7	1.7	6.5	fix	4.85	1.46	0.009	N/A	0.022	1.6	0.005	N/A	0.012	N/A	-	S1
Body	Front	0	Battery	BT LE(2M)	1Tx		2	2480	39	58.7	1.7	6.5	fix	5.14	1.37	0.011	N/A	0.026	1.6	0.005	N/A	0.012	N/A	-	S1
Body	Back	0	Battery	BR	1Tx	•	1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.006	N/A	0.011	1.6	0.003	N/A	0.005	N/A	-	S2
Body	Тор	0	Battery	BR	1Tx	•	1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.005	N/A	0.009	1.6	0.003	N/A	0.005	N/A	-	S3
Body	Bottom3	0	Battery	BR	1Tx		1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.009	N/A	0.016	1.6	0.005	N/A	0.009	N/A	-	S4
Body	Left	0	Battery	BR	1Tx		1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.004	N/A	0.007	1.6	0.002	N/A	0.004	N/A	-	S5
Body	Right	0	Battery	BR	1Tx	-	1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	0.003	N/A	0.005	1.6	0.001	N/A	0.002	N/A	-	S6
Body	Bottom2	0	Battery	BR	1Tx	-	1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	exempt	N/A	NΑ	1.6	exempt	N/A	N/A	N/A	-	-
Hand	Bottom1	0	Battery	BR	1Tx		1	2441	39	77.6	1.29	6.5	fix	5.13	1.37	exempt	N/A	NΑ	N/A	exempt	N/A	N/A	4	-	-

Exempt: SAR test is exempted by evaluated SAR test exclusion threshold power. See section 4.

7.2 Simultaneous transmission (including Co-location) evaluation

Result: Simultaneous transmission is not existed.

7.3 SAR Measurement Variability (Repeated measurement requirement)

Result: Since all the measured SAR are less than 0.8 W/kg (SAR(1g)), the repeated measurement is not required.

7.4 Device holder (D/H) perturbation verification (SAR)

Result: Since all the reported (scaled) SAR are less than 1.2 W/kg (SAR(1g)), the additional "device holder perturbation verification" measurement is not considered.

7.5 Requirements on the Uncertainty Evaluation

Decision Rule

☑ Uncertainty is not included.

☐ Uncertainty is included.

Ant.: Antenna; D/R: Data rate; Frequency; Duty: Duty cycle; D.S/F: Duty Scaling Factor, Pmax: Max power (Tune-up tolerance power); Pmeas:: Measurement conducted power, P.S/F Power Scaling Factor, Meas:: Measurement; Appx: Appendix; Gap: It is separation distance between the device surface and the bottom outer surface of phantom. All SAR tests were conservatively performed with test separation distance 0 mm.

Before test, the battery was full charged. During SAR test, the radiated power is always monitored by Spectrum Analyzer or/and MAIA.

Since the calculated Δ SAR values of the tested liquid had shown positive correction even when error was more than 5%, the measured SAR was not converted by Δ SAR correction.

Calculating formula: \triangle SAR corrected SAR (W/kg) = (Measured SAR (W/kg)) × (100 - (\triangle SAR(%))) / 100, when \triangle SAR shows negative sign.

Calculating formula: Reported (Scaled) SAR (W/kg) = (Measured SAR (W/kg)) × (Duty scaled factor) × (Power scaled factor) where, Duty scaled factor (D.S/F) [-] = 100(%) / (measured duty cycle, %), Power scaled factor (P.S/F) [-] = 10^ (((Max.power, dBm) - (Measured power, dBm)) / 10)

The highest measured SAR(1g) is less than 1.5 W/kg and the highest measured SAR(10g) is less than 3.75 W/kg. Thus, per KDB Publication 865664 D01, the extended measurement uncertainty analysis described in IEEE 1528-2013 is not required.

APPENDIX 2: Measurement data

Appendix 2-1: Plot(s) of Worst Reported Exposure Value

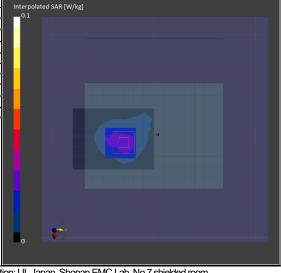
Plot D1: Front & touch, BT LE(1 Mbps), 2480 MHz

EUT: Game Controller; Model: BEE-021; Serial:HHL0400006178

Mode: BT LE (1 Mbps) (UID: 0 (CW)); Frequency: 2480 MHz; Test Distance: 0.00 mm TSL parameters used: Head(v6); f= 2480 MHz; Conductivity: 1.889 S/m; Permittivity: 39.63

DASY8 Configuration: - Electronics: DAE4 - SN626 (Calibrated: 2024-01-09) / - Phantom: ELI V8.0 (20deg probe tilt); Serial: 2161; Phantom section: Flat - Probe: EX3DV4 - SN3907(Calibrated: 2024-01-15); ConvF: (6.83, 7.07, 6.68) @ 2480 MHz/ - Software: 16.4.0.5005 (Measurement); 16.4.0.5005 (Evaluation)

	Scan S	Setup	Measurement Results					
Setup items	Fast	Area	Zoom	Meas. Items	Area	Zoom		
Grid Extents [mm]	180.0x140.0	80.0×60.0	30.0×30.0×30.0	psSAR 1g [W/kg]	0.017	0.018		
Grid Steps [mm]	10.0x10.0	10.0×10.0	5.0×5.0×1.5	psSAR 10g [W/kg]	0.009	0.01		
Sensor Distance [mm]	4.0	3.0	1.4	Power Drift [dB]	0.11	0.19		
Graded Grid	N/A	N/A	Yes	pSAR (extrapolated) [W/kg]	N/A	0.032		
Grading Ratio	N/A	N/A	1.5	Power Scaling	Disabled	Disabled		
MAIA monitored	N/A	Υ	Υ	TSL Correction	No correction	No correction		
Surface Detection	VMS+6p	VMS+6p	VMS+6p	M2/M1 [%]	N/A	81.7		
Scan Method	Measured	Measured	Measured	Dist 3dB Peak [mm]	N/A	14.4		
Grid Effective [mm]	N/A	80.0×60.0	30.0×30.0×31.2	SAR1g Position (x,y,z)	N/A	6.5, -29.7, -172.0		



*. Order No.: 15407883; Date tested: 2024-10-24; Tested by: A. Oda; Tested location: UL Japan, Shonan EMC Lab. No.7 shielded room

*. Liquid temperature: 22.5 deg.C. ± 0.5 deg.C. (22.5 deg.C., in check); Ambient 23 deg.C. / 76 %RH; *. Red cubic: big=SAR(10g) / small=SAR(1g) *. Project file name-Measurement Group: 241024_15407883_bee-021_hac.d8sar-241024-6,ble,2480m,front

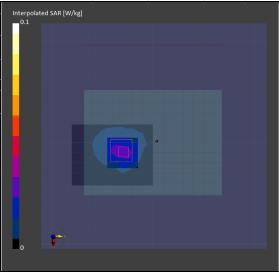
Plot D2: Front & touch, BR(DH5), 2480 MHz

EUT: Game Controller; Model: BEE-021; Serial:HHL04000006178

Mode: BR (DH5) CW (UID: 0 (CW)); Frequency: 2480 MHz; Test Distance: 0.00 mm TSL parameters used: Head(v6); f= 2480 MHz; Conductivity: 1.889 S/m; Permittivity: 39.63

DASY8 Configuration: - Electronics: DAE4 - SN626 (Calibrated: 2024-01-09) / - Phantom: ELI V8.0 (20deg probe tilt); Serial: 2161; Phantom section: Flat - Probe: EX3DV4 - SN3907(Calibrated: 2024-01-15); ConvF: (6.83, 7.07, 6.68) @ 2480 MHz/ - Software: 16.4.0.5005 (Measurement); 16.4.0.5005 (Evaluation)

	Scan S	etup	Measuren	nent Resu	ults	
Setup items	Fast	Area	Zoom	Meas. Items	Area	Zoom
Grid Extents [mm]	180.0x140.0	80.0×60.0	30.0×30.0×30.0	psSAR 1g [W/kg]	0.016	0.015
Grid Steps [mm]	10.0x10.0	10.0×10.0	5.0×5.0×1.5	psSAR 10g [W/kg]	0.009	0.008
Sensor Distance [mm]	4.0	3.0	1.4	Power Drift [dB]	0.01	-0.18
Graded Grid	N/A	N/A	Yes	pSAR (extrapolated) [W/kg]	N/A	0.063
Grading Ratio	N/A	N/A	1.5	Power Scaling	Disabled	Disabled
MAIA monitored	N/A	Υ	Y	TSL Correction	No correction	No correction
Surface Detection	VMS+6p	VMS+6p	All points	M2/M1 [%]	N/A	79.5
Scan Method	Measured	Measured	Measured	Dist 3dB Peak [mm]	N/A	13.5
Grid Effective [mm]	N/A	80.0×60.0	30.0×30.0×31.2	SAR1g Position (x,y,z)	N/A	9.3, -29.1, -171.8



*. Order No.: 15407883; Date tested:2024-10-24; Tested by: A. Oda; Tested location: UL Japan, Shonan EMC Lab. No.7 shielded room

*. Liquid temperature: 22.5 deg.C. ± 0.5 deg.C. (22.5 deg.C., in check); Ambient: 23 deg.C. / 63 %RH; *. Red cubic: big=SAR(10g) / small=SAR(1g)

*. Project file name-Measurement Group: 241024_15407883_bee-021_hac.d8sar-241024-3,br;2480m,front

APPENDIX 3: Test instruments

Appendix 3-1: Equipment used

Test Name	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Interval (Month)
AT	191844	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	-	2024/08/10	12
AT	169910	Power Meter	Keysight Technologies Inc	8990B	MY51000448	2024/09/11	12
AT	169911	Power sensor	Keysight Technologies Inc	N1923A	MY57270004	2024/09/11	12
AT	236500	Attenuator	To-Conne Co., Ltd.	SA-PJ-10	-	2023/12/04	12
AT	245174	Coaxial Cable	Hayashi-Repic ∞., Ltd.	KMS020B-GL140sE-KMS020B-2.0m	49334-01-01	2024/02/14	12
AT	145800	Spectrum Analyzer	Keysight Technologies Inc	E4448A	MY48250106	2024/03/25	12

^{*.} AT was measured 2024-10-09. (Refer to Section 5 in this report.)

Test Name	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Interval (Month)
SAR	224031	DASY8 Module SAR/APD soft	Schmid & Partner Engineering AG	ver.16.4.5005	9-2506F07D	-	-
SAR	144886	Dielectric assessment kit soft	Schmid & Partner Engineering AG	DAK ver.3.0.6.14	9-0EE103A4	-	-
SAR	224020	DASY8 PC	Hewlett Packard	HP Z4 G4 Workstation	CZC1198G21	-	-
SAR	225155	Mounting Platform	Schmid & Partner Engineering AG	MP8E-TX2-60L Basic	-	-	-
SAR	224032	6-axis Robot	Schmid & Partner Engineering AG	TX2-60L spe	F/22/0033789/A/001	2024/08/05	12
SAR	224023	Robot Controller	Schmid & Partner Engineering AG	CS9spe-TX2-60	F/22/0033789/C/001	-	-
SAR	224025	Measurement Server	Schmid & Partner Engineering AG	DASY8 Measurement Server	10042	2024/06/04	12
SAR	224026	Electro-Optical Converter	Schmid & Partner Engineering AG	EOC8-60	1027	-	-
SAR	224027	Light Beam Unit	Schmid & Partner Engineering AG	LIGHTBEAM-85	2069	-	-
SAR	227155	SP2 Manual Control Pendant	Schmid & Partner Engineering AG	D21144507 C	22066839	-	-
SAR	144944	Data Acquisition Electronics	Schmid & Partner Engineering AG	DAE4	626	2024/01/09	12
SAR	146235	Dosimetric E-Field Probe	Schmid & Partner Engineering AG	EX3DV4	3907	2024/01/15	12
SAR	224034	Flat Phantom	Schmid & Partner Engineering AG	ELI V8.0	2161	2024/08/05	12
SAR	145596	Device holder	Schmid & Partner Engineering AG	Mounting device for transmitter	-	2024/08/05	12
SAR	224028	Modulation & Audio Interference Analyzer	Schmid & Partner Engineering AG	MAIA	1582	-	-
SAR	145090	Dipole Antenna (2.45 GHz)	Schmid & Partner Engineering AG	D2450V2	822	2024/01/05	12
SAR	230872	RF Power Source	Schmid & Partner Engineering AG	POWERSOURCE1	4300	2024/01/03	12
SAR	145500	Dielectric probe	Schmid & Partner Engineering AG	DAK3.5	1129	2024/01/16	12
SAR	146258	Network Analyzer	Keysight Technologies Inc	8753ES	US39171777	2024/10/10	12
SAR	145106	Ruler(150mm,L)	SHINWA	12103	-	2024/02/26	12
SAR	145086	Ruler(300mm)	SHINWA	13134	-	2024/02/26	12
SAR	145087	Ruler(100x50mm,L)	SHINWA	12101	-	2024/02/26	12
SAR	150560	Ruler(150mm)	SHINWA	14001	-	2024/02/26	12
SAR	144986	Thermo-Hygrometer data logger	SATO KEIRYOKI	SK-L200THIIa/SK-LTHIIa-2	015246/08169	2024/08/10	12
SAR	201967	Digital thermometer	HANNA	Checktemp-4	A01440226111	2024/08/10	12
SAR	201968	Digital thermometer	HANNA	Checktemp-4	A01310946111	2024/08/10	12
SAR	191844	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	-	2024/08/10	12
SAR	146176	Spectrum Analyzer	ADVANTEST	R3272	101100994	-	-
SAR	146185	DI water	MonotaRo	34557433	-	-	-
SAR	146112	Primepure Ethanol	Kanto Chemical Co., Inc.	14032-79	-	-	-
SAR	207714	Head Tissue Simulating Liquid	Schmid & Partner Engineering AG	HBBL600-10000V6	SL AAH U16 BC	-	-

^{*.} SAR test was performed 2024-10-24.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chain of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

[Test Item] AT: Antenna terminal conducted power, SAR: Specific Absorption Rate

The expiration date of calibration is the end of the expired month.

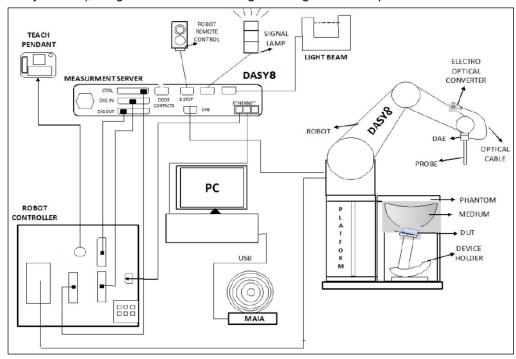
^{*.} Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

LIMS ID: 146112, the parameters of primepure Ethanol (as reference liquid) used for the simulated tissue parameter confirmation was defined the NPL Report MAT23 (http://www.npl.co.uk/content/conpublication/4295)

Appendix 3-2: Measurement System

Appendix 3-2-1: SAR Measurement System

These measurements were performed with the automated near-field scanning system DASY8 from Schmid & Partner Engineering AG (SPEAG). The system is based on a high precision robot), which positions the probes with a positional repeatability of better than \pm 0.03 mm. Special E- and H-field probes have been developed for measurements close to material discontinuity, the sensors of which are directly loaded with a Schottky diode and connected via highly resistive lines to the data acquisition unit. The SAR measurements were conducted with the dosimetry probes EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.



The DASY8 SAR/APD system for performing compliance tests consist of the following items:

- 6-axis robotic arm (Stäubli TX2-60L) for positioning the probe
- Mounting Platform for keeping the phantoms at a fixed location relative to the robot
- Measurement Server for handling all time-critical tasks, such as measurement data acquisition and supervision of safety features
- EOC (Electrical to Optical Converter) for converting the optical signal from the DAE to electrical before being transmitted to the measurement server
- LB (Light-Beam unit) for probe alignment (measurement of the exact probe length and eccentricity)
- SAR probe (EX3DV4 probes) for measuring the E-field distribution in the phantom. The SAR distribution and the psSAR (peak spatial averaged SAR) are derived from the E-field measurement.
- SAR phantom that represents a physical model with an equivalent human anatomy. A Specific Anthropomorphic Mannequin (SAM) head is usually used for handheld devices, and a Flat phantom is used for body-worn devices.
- TSL (Tissue Simulating Liquid) representing the dielectric properties of used tissue, e.g. Head Simulating Liquid, HSL.
- DAE (Data Acquisition Electronics) for reading the probe voltages and transmitting it to the DASY8 PC.
- Device Holder for positioning the DUT beneath the phantom.
- MAIA (Modulation and Interference Analyzer) for confirming the accuracy of the probe linearization parameters
- Operator PC for running the DASY8 software to define/execute the measurements
- System validation kits for system check/validation purposes.

Platforms

The platform is a multi-phantom support structure made of a wood and epoxy composite (ϵ = 3.3 and loss tangent δ < 0.07). It is a strong and rigid structure transparent to electric and magnetic fields (nonmetallic components).

TX2-60L robot, CS9 robot controller

•Number of Axes : 6 •Repeatability : ±0.03 mm •Manufacture : Stäubli

DASY8 Measurement server

The DASY8 Measurement Server handles all time critical tasks such as acquisition of measurement data, detection of phantom surface, control of robot movements, supervision of safety features.

•Manufacture : Schmid & Partner Engineering AG

Data Acquisition Electronic (DAE)

The DAE is used to acquire the probe sensor voltages and transfer them to the DASY8 Measurement Server, and to report mechanical surface detection and probe collisions. The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16-bit AD-converter, and a command decoder with a control logic unit. Transmission to the DASY8 Measurement Server is accomplished through an optical downlink for data and status information and an optical uplink for commands and the clock. The mechanical probe mounting device includes two different sensor systems for frontal and sideways probe contacts used for mechanical surface detection and probe collision detection.

•Measurement Range : 1 μ V to > 200 mV (2 range settings: 4 mV (low), 400 mV (high)) •Input Offset voltage : <1 μ V (with auto zero) •Input Resistance : 200 M Ω •Battery operation : >10 hrs. (with two rechargeable 9 V battery)

Schmid & Partner Engineering AG

Electro-Optical Converter (EOC8-TX2-60L)

The Electrical to Optical Converter (EOC8) supports as data exchange between the DAE and the measurement server (optical connector) and data acquisition based on Ethernet protocol.

Manufacture : Schmid & Partner Engineering AG

Light Beam Switch

Manufacture

The light beam unit allows automatic "tooling" of the probe. During the process, the actual position of the probe tip with respect to the robot arm, as well as the probe length and the horizontal probe offset, are measured. The software then corrects all movements within the measurement jobs, such that the robot coordinates are valid for the probe tip. The repeatability of this process is better than 0.1 mm. If a position has been taught with an aligned probe, the same position will be reached with another aligned probe within 0.1 mm, even if the other probe has different dimensions. During probe rotations, the probe tip will keep its actual position.

Manufacture : Schmid & Partner Engineering AG

SAR measurement software

Software version : Refer to Appendix 3-1 (Equipment used)
 Manufacture : Schmid & Partner Engineering AG

E-Field Probe

•CF

enclosure material (resistant to organic solvents, e.g., DGBE).

Refer to calibration data of Appendix. (CF: Conversion Factors)

•Directivity : ± 0.1 dB in TSL (rotation around probe axis)/ ± 0.3 dB in TSL (rotation normal to probe axis)

Dynamic Range: 10 μW/g to > 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μW/g)
 Dimension: Overall length: 330 mm (Tip: 20 mm)/Tip diameter: 2.5 mm (Body: 12 mm)
 Typical distance from probe tip to dipole centers: 1mm

•Application : High precision dosimetric measurement in any exposure scenario (e.g., very strong gradient

fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of

better 30%.

•Manufacture : Schmid & Partner Engineering AG

ELI Phantom

The ELI phantom is used for compliance testing of handheld and body-mounted wireless devices in the frequency range of 4 MHz to 10 GHz. ELI is fully compatible with the IEC/IEEE 62209-1528 standard and all known tissue simulating liquids.

ELI V8.0 phantom shell has optimized pretension in the bottom surface during production, such that the phantom is more robust and with reduced sagging.

•Model Number : ELI V8.0 flat phantom
•Shell Material : Vinyl ester, fiberglass reinforced (VE-GF)
•Shell Thickness : 2.0 ± 0.2 mm (bottom plate)
•Dimensions : 600 mm × 400 mm (oval) (volume: Approx. 30 liters)

•Manufacture : Schmid & Partner Engineering AG

Device Holder, Laptop holder, support material

Accurate device positioning is crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards. The device holder is designed to cope with the different positions given in the standard. It has two scales for device rotation (with respect to the body axis) and device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles. The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ϵ =3 and loss tangent δ =0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.

Device holder: In combination with the ELI phantom, the Mounting Device enables the rotation of the mounted transmitter device in spherical coordinates. Transmitter devices can be easily and accurately positioned. The low-loss dielectric urethane foam was used for the mounting section of device holder.

Material: Polyoxymethylene (POM)
 Manufacture: Schmid & Partner Engineering AG
 Laptop holder: A simple but effective and easy-to-use extension for the Mounting Device; facilitates testing of larger devices (e.g., laptops, cameras, etc.) according to IEC/IEEE 62209-1528.

•Material: Polyoxymethylene (POM), PET-G, Foam•Manufacture: Schmid & Partner Engineering AG

Support form: Urethane foam













Data storage and evaluation (post processing)

SAR

Etot

σ

with

The uplink signal transmitted by the DUT is measured inside the TSL by the probe, which is accurately positioned at a precisely known distance and with a normal orientation with respect to the phantom surface. The dipole / loop sensors at the probe tips pick up the signal and generate a voltage, which is measured by the voltmeter inside the DAE. The DAE returns digital values, which are converted to an optical signal and transmitted via the EOC to the measurement server. The data is finally transferred to the DASY8 software for further post processing. In addition, the DASY8 software periodically requests a measurement with short-circuited inputs from the DAE to compensate the amplifier offset and drift. This procedure is called DAE zeroing.

The operator has access to the following low level measurement settings:

- the integration time is the voltage acquisition time at each measurement point. It is typically 0.5 s.
- the zeroing period indicates how often the DAE zeroing is performed.

In parallel, the MAIA measures the characteristics of the uplink signal via the air interface and sends this information to the DASY8 software, which compares them to the communication system defined by the operator. A warning is issued if any difference is detected.

The measurement data is now acquired and can be post processed to compute the psSAR1g /8g /10g.

The measured voltages are not directly proportional to SAR and must be linearized. The formulas below are based on [1] (*1). The measured voltage is first linearized using the (a, b, c, d) set of parameters specific to the communication system and sensor:

 $V_{compi} = U_i + U_i^2 \cdot \frac{10^{\frac{d}{10}}}{d_{cp_i}}$ with = compensated voltage of channel i (μV) Vcompi (i = x,y,z)= input voltage of channel i (μV) (i = x,y,z)Ui (Probe parameter) = PMR factor d (dB) d = diode compression point of channel i (μV) (Probe parameter, i = x,y,z) dcpi $V_{compi_{dB},\sqrt{uV}} = 10 \cdot \log_{10}(V_{compi})$ $corr_i = a_i \cdot e^{-\left(\frac{b_i - 10 \log_{10}(V_{compi})}{c_i}\right)^2}$ with = correction factor of channel i (dB) (i = x,y,z)comi (i = x,y,z)= compensated voltage of channel i (dB $\sqrt{\mu V}$) Vcompi_{dB√uV}) = PMR factor a of channel i (dB) (Probe parameter, i = x,y,z) = PMR factor b of channel $i(dB\sqrt{\mu V})$ (Probe parameter, i = x,y,z) bi Ci = PMR factor c of channel i (-) (Probe parameter, i = x,y,z) The voltage $V_{\text{laB}\sqrt{\mu V})}$ is the linearized voltage in dB $\sqrt{\mu V}$): $V_{i_{dB\sqrt{\mu V}}} = V_{compi_{dB\sqrt{\mu V}}} - corr_i$ $V_{idB\sqrt{uV}}$ = linearized voltage of channel i (dB $\sqrt{\mu V}$) (i = x,y,z)= compensated voltage of channel i (dB $\sqrt{\mu V}$) $\textit{VcompidB}_{\sqrt{\mu V})}$ (i = x,y,z)= PMR factor a of channel i (dB) Corri (i = x,y,z)Finally, the linearized voltage is converted in μV : = linearized voltage of channel i (μV) with Vi (i = x,y,z)(i = x,y,z)= linearized voltage of channel i (dB $\sqrt{\mu V}$) $V_{compi_{dB}\sqrt{\mu V}})$ The Field data for each channel are calculated using the linearized voltage: E-filedprobes: = linearized voltage of channel i in μV with Vi (i = x,y,z)= sensor sensitivity of channel i in μV/(V/m)2 for E-field Probes (i = x,y,z)Nomi ConvF = sensitivity enhancement in solution = electric field strength of channel i in V/m (i = x.v.z)The RMS value of the field components gives the total field strength (Hermitian magnitude): $E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$ The E-field data value is used to calculate SAR:

Note: The resulting linearized voltage is only approximated because the probe UID is used 0 (CW) for the test signal in this test report.

 $SAR = E_{tot}^2 \cdot \frac{\sigma}{\sigma \cdot 1000}$

= local specific absorption rate in mW/g

= equivalent tissue density in g/cm³

= total field strength in V/m = conductivity in $[\Omega/m]$ or [S/m]

(*1) [1] Jagadish Nadakuduti, Sven Kuehn, Marcel Fehr, Mark Douglas Katja Pokovic and Niels Kuster, "The Effect of Diode Response of electromagnetic Field Probes for the Measurements of Complex Signals." IEEE Transactions on Electromagnetic Compatibility, vol. 54, pp. 1195–1204, Dec. 2012.

Appendix 3-2-2: SAR system check results

Prior to the SAR assessment of EUT, the Daily check was performed to test whether the SAR system was operating within its target of $\pm 10\%$. The Daily check results are in the table below.

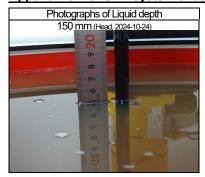
Liquid type:	Head	ΔS	AR	P.in	SAR (1g) [W/kg] (*b)				b)			SAR (10g) [W/kg] (*b)							Dev.
Date	Freq.	1g	10g		Meas.	1W	Target (*c)		Dev	Dev.[%] Pa		Meas.	1W	Targe	et (*c)	Dev.[%]		Pass	limit
Date	[MHz]	[%]	[%]	[dBm]	(*a)	scaled	CAL.	STD	CAL.	STD	?	(*a)	scaled	CAL.	STD	Cal.	STD	?	[%]
2024-10-24	2450	1.4	0.7	17.01	2.69	52.8	53.4	52.4	-1.1	8.0	Pass	1.26	24.9	25	24	-0.4	3.7	Pass	±10

Freq: Frequency, Meas: Measurement, CAL: Value of Calibration, STD: Value of Standard, Dev. Deviation,

- (2.45 GHz) The Measured SAR/value is obtained at 17 dBm (50 mW) setting of POWERSOURCE1 (LIMS ID#230872, S/N: 4300) calibrated by Schmid & Partner Engineering AG, the data sheet was filed in this report.
- The measured SAR value of Daily of oct was compensated for tissue dielectric deviations (\(\Delta SAR \)) and scaled to 1W of output power in order to compare with the manufacture's calibration target value which was normalized.

- $\Delta SAR \ corrected \ SAR \ (1g) \ (W/kg) = (Measured \ SAR(1g) \ (W/kg)) \times (100 (\Delta SAR1g(\%)) / 100$ $\Delta SAR \ corrected \ SAR \ (10g) \ (W/kg) = (Measured \ SAR(10g) \ (W/kg)) \times (100 (\Delta SAR10g(\%)) / 100$ The target value is a parameter defined in the calibration data sheet of D2450V2 (sn:822) dipole, calibrated by Schmid & Partner Engineering AG, the data sheet was filed in this report.
 The target value (normalized to 1W) is defined in IEEE Std.1528.

Appendix 3-2-3: SAR system check measurement data



Dipole: D2450V2-822 2401; Mode: CW(0); Frequency: 2450 MHz; Test Distance: 10 mm (dipole to liquid); Power setting: 17.0 dBm TSL parameters used: Head(v6); f= 2450 MHz; Conductivity: 1.863 S/m; Permittivity: 39.68

DASY8 Configuration: - Electronics: DAE4 - SN626(Calibrated:2024-01-09) - Phantom: ELI V8.0 (20deg probe tilt); Serial: 2161; Phantom section: Flat - Probe: EX3DV4 - SN3907(Calibrated: 2024-01-15); ConvF: (6.83, 7.07, 6.68) @2450 MHz/ - Software: 16.4.0.5005 (Measurement); 16.4.0.5005 (Evaluation)

	Scan	Setup		Measur	ement Result	ts
Setup Items	Fast	Area	Zoom	Meas. Items	Area	Zoom
Grid Extents [mm]	40.0x80.0	40.0×80.0	30.0×30.0×30.0	psSAR1g [W/kg]	2.69	2.69
Grid Steps [mm]	10.0x10.0	10.0×10.0	5.0×5.0×1.5	psSAR10g [W/kg]	1.25	1.26
Sensor Distance [mm]	4.0	3.0	1.4	Power Drift [dB]	-0.00	0.01
Graded Grid	N/A	N/A	Yes	pSAR (extrapolated) [W/kg]	N/A	5.54
Grading Ratio	N/A	N/A	1.5	Power Scaling	Disabled	Disabled
MAIA monitored	N/A	Y	Y	TSL Correction	No correction	No correction
Surface Detection	VMS+6p	All points	All points	M2/M1 [%]	N/A	80.1
Scan Method	Measured	Measured	Measured	Dist 3dB Peak [mm]	N/A	9.1
Grid Effective [mm]	N/A	40.0×80.0	30.0×30.0×31.2	psSAR8g [W/kg]	1.38	1.39
·			•	PD 1 cm ² -sq. [W/m ²]	N/A	N/A
				PD 4 cm ² -sq. [W/m ²]	N/A	N/A

Remarks: *. Order No.: , *. Date tested:2024-10-24 ; Tested by: A. Oda; Tested location: UL Japan, Shonan EMC Lab. No.7 shielded room

*. Liquid temperature: 22.2 deg.C. ± 0.5 deg.C. (22.2 deg.C., in check); Ambient: 22 deg.C. / 71 %RH; *. Red cubic: big=SAR(10g) / small=SAR(1g) *. Project file name-Measurement Group: 241024_15407883_bee-021_hac.d8sar-SPC Measurement Group

Appendix 3-3: **Measurement Uncertainty**

- Measurement system (DASY8) CF Probe Calibration (EX3DV4) (*.HSL:10%)	Uncertainty of SAR measurement (2.4GHz~6GHz) (*. liquid: head(v6), DAK, WLAN)										SA	R 10g
CF Probe Calibration (EX3DV4) (*.HSL:10%)	Symbol	•	Un	nc. [%]		Divisor	ci 1g	ci 10g	ui	1g [%]	ui 1	l0g [%]
CFdfift	-	Measurement system (DASY8)										
LIN	CF	Probe Calibration (EX3DV4) (*.HSL:10%)	±	14.0	Normal	2	1	1	±	7.0	±	7.0
BBS Broadband Signal	CFdfift	Probe Calibration Drift	±	1.7	Rectangular	√3	1	1	±	1.0	±	1.0
SO	LIN	Probe Linearity	±	4.7	Rectangular	√3	1	1	±	2.7	±	2.7
DAE Data Acquisition	BBS	Broadband Signal	±	2.6	Rectangular	√3	1	1	±	1.5	±	1.5
AMB RF Ambient (noise&refrection) (< 12 W/g)	ISO	Probe Isotropy	±	7.6	Rectangular	√3	1	1	±	4.4	±	4.4
∆sys Probe Positioning ± 0.5 Normal 1 0.29 0.29 ± 0.2 ± DAT Data Processing ± 4.0 Rectangular √3 1 1 ± 2.3 ± LIQ(σ) Conductivity (measured) (DAK) ± 5.0 Normal 2 0.78 0.71 ± 2.0 ± LIQ(To) Conductivit (temp.)(1°C,v6°-head) ± 2.4 Rectangular √3 0.78 0.71 ± 1.1 ± EPS Phantom Permittivity ± 14.0 Rectangular √3 0.25 0.25 ± 2.0 ± DIS Distance EUT-TSL (liqant:5mm) ± 2.7 Normal 1 2 2 ± 5.4 ± DSyz Test Sample positioning ± 1.8 Normal 1 1 1 ± 1.8 ± ± 1.8 Normal 1 1 ± 1.8 ±	DAE	Data Acquisition	±	1.2	Normal	1	1	1	±	1.2	±	1.2
DAT Data Processing	AMB	RF Ambient (noise&refrection) (< 12 W/g)	±	1.0	Normal	1	1	1	±	1.0	±	1.0
- Phantom and Device Error LIQ(σ) Conductivity (measured) (DAK)	∆sys	Probe Positioning	±	0.5	Normal	1	0.29	0.29	±	0.2	±	0.2
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	DAT		±	4.0	Rectangular	√3	1	1	±	2.3	±	2.3
LIQ(Tσ) Conductivit (temp.)(1°C,γ6-head) ± 2.4 Rectangular √3 0.78 0.71 ± 1.1 ± EPS Phantom Permittivity ± 14.0 Rectangular √3 0.25 0.25 ± 2.0 ± DIS Distance EUT-TSL (liqant:5mm) ± 2.7 Normal 1 2 2 ± 5.4 ± Dxyz Test Sample positioning ± 1.8 Normal 1 1 1 ± 1.8 ± H Device holder uncertainty ± 3.6 Normal 1 1 1 ± 3.6 ± MOD EUT Modulation ± 2.4 Normal √3 1 1 ± 1.4 ± TAS Time-average SAR ± 0.0 Rectangular √3 1 1 ± 0.0 ± RFdiff Drift of output power (measured, <0.2 dB)	-	Phantom and Device Error										
EPS Phantom Permittivity ± 14.0 Rectangular √3 0.25 0.25 ± 2.0 ± DIS Distance EUT-TSL (liqant:5mm) ± 2.7 Normal 1 2 2 ± 5.4 ± Dxyz Test Sample positioning ± 1.8 Normal 1 1 1 ± 1.8 ± H Device holder uncertainty ± 3.6 Normal 1 1 1 ± 1.8 ± MOD EUT Modulation ± 2.4 Normal 1 1 1 ± 3.6 ± TAS Time-average SAR ± 0.0 Rectangular √3 1 1 ± 1.4 ± TAS Time-average SAR ± 0.0 Rectangular √3 1 1 ± 0.0 ± REdiffit Drift of output pow er (measured, <0.2 dB) ± 4.7 Normal 2 1 1 ± 2.4 ± Correction to the SAR results C(e,σ) Deviation to Target (e',σ:10 %, IEC head) ± 1.9 Normal 1 1 0.84 ± 1.9 ± C(R) SAR Scaling ± 0.0 Rectangular √3 1 1 ± 0.0 ± RSS ± 12.3 ± 1	LIQ(σ)	Conductivity (measured) (DAK)	±	5.0	Normal	2	0.78	0.71	±	2.0	±	1.8
DIS Distance EUT-TSL (liqant:5mm) ± 2.7 Normal 1 2 2 ± 5.4 ± Dxyz Test Sample positioning ± 1.8 Normal 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 3 6 ± MOD BUT Modulation ± 2.4 Normal √3 1 1 ± 1.4 ± TAS Time-average SAR ± 0.0 Rectangular √3 1 1 ± 0.0 ± RFdfift Drift of output power (measured, <0.2 dB)	LIQ(Tσ)		±	2.4	Rectangular	√3	0.78	0.71	±	1.1	±	1.0
Dxyz Test Sample positioning ± 1.8 Normal 1 1 ± 1.8 ± H Device holder uncertainty ± 3.6 Normal 1 1 ± 3.6 ± MOD EUT Modulation ± 2.4 Normal √3 1 1 ± 1.4 ± TAS Time-average SAR ± 0.0 Rectangular √3 1 1 ± 1.4 ± RFdfift Drift of output power (measured, <0.2 dB) ± 4.7 Normal 2 1 1 ± 2.4 ± - Correction to the SAR results C(e,σ) Deviation to Target (e',σ:10 %, IEC head) ± 1.9 Normal 1 1 0.84 ± 1.9 ± C(R) SAR Scaling ± 0.0 Rectangular √3 1 1 ± 0.0 ± u(ΔSAR) Combined standard uncertainty RSS ± 12.3 ± 1.9 RSS ± 12.3 ± 1.8 ± Tast Normal 1 1 1 1 1 1 1 Tast Normal 1 1 1 1 1 Tast Normal 1 1 1 1 Tast Normal 1 1 1 1 Tast Normal 1 Tast Normal	EPS		±	14.0	Rectangular	√3	0.25	0.25	±	2.0	±	2.0
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	DIS	Distance EUT-TSL (liqant:5mm)	±	2.7	Normal	1	2	2	±	5.4	±	5.4
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dxyz	Test Sample positioning	±	1.8	Normal	1	1	1	±	1.8	±	1.8
TAS Time-average SAR \pm 0.0 Rectangular $\sqrt{3}$ 1 1 \pm 0.0 \pm RFdflft Drift of output pow er (measured, <0.2 dB) \pm 4.7 Normal 2 1 1 \pm 2.4 \pm \pm - Correction to the SAR results $C(e,\sigma)$ Deviation to Target (e', σ :10 %, IEC head) \pm 1.9 Normal 1 1 0.84 \pm 1.9 \pm C(R) SAR Scaling \pm 0.0 Rectangular $\sqrt{3}$ 1 1 \pm 0.0 \pm u(Δ SAR) Combined standard uncertainty			±		Normal	1	1	1	±	3.6	±	3.6
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	MOD	EUT Modulation	±	2.4	Normal	√3	1	1	±	1.4	±	1.4
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			±	0.0	Rectangular	√3	1	1	±		±	0.0
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	RFdfift	Drift of output pow er (measured, <0.2 dB)	±	4.7	Normal	2	1	1	±	2.4	±	2.4
C(R) SAR Scaling \pm 0.0 Rectangular $\sqrt{3}$ 1 1 \pm 0.0 \pm u(Δ SAR) Combined standard uncertainty RSS \pm 12.3 \pm 1	-											
u(Δ SAR) Combined standard uncertainty RSS \pm 12.3 \pm 1.	C(e, \sigma)	Deviation to Target (e',σ:10 %, IEC head)	±	1.9	Normal	1	1	0.84	±	1.9	±	1.6
` '	C(R)		±	0.0	Rectangular	√3	1	1	±	0.0	±	0.0
U Expand uncertainty (95% confidence interval) (v11r06) k=2 ± 24.6 ± 2	u(ΔSAR)	(Combined standard uncertainty								12.3	±	12.3
	U	Expand uncertainty (95% confidence interval) (v11r06)								24.6	±	24.6

This uncertainty budget is suggested by IEC/IEEE 62209-1528 and determined by SPEAG, DASY8 Module SAR Manual, 2024-05 (Chapter 6.3, DASY8 Uncertainty Budget for Hand-held/Body-worn Devices, Frequency band: 300 MHz - 3 GHz range and 3 GHz - 6 GHz range). All listed error components have veff equal to ∞.

	Uncertainty of SAR daily check (2.4GHz~6GHz) (*.liquid: head(v6), DAK, CW)										√R 10g
Sy mbol	Error Description	Ur	nc. [%]	Probablity distribution	Divisor	ci 1g	ci 10g	ui	1g [%]	ui 1	0g [%]
-	Measurement system (DASY8)										
CF	Probe Calibration (EX3DV4) (*.HSL:10%)	±	14.0	Normal	2	1	1	±	7.00	±	7.00
CFdfift	Probe Calibrationr Drift	±	1.7	Rectangular	√3	1	1	±	1.0	±	1.0
LIN	Probe Linearity	±	4.7	Rectangular	√3	1	1	±	2.7	±	2.7
ISO	Probe Isotropy	√3	1	1	±	2.7	±	2.7			
DAE	Data Acquisition	±	1.2	Normal	1	1	1	±	1.2	±	1.2
AMB	RF Ambient (noise&refrection) (< 12 W/g)	±	1.0	Normal	1	1	1	±	1.0	±	1.0
∆sys	Probe Positioning	±	0.5	Normal	1	0.29	0.29	±	0.2	±	0.2
DAT	Data Processing	±	4.0	Rectangular	√3	1	1	±	2.3	±	2.3
-	Phantom and Device Error										
LIQ(σ)	Conductivity (measured) (DAK)	±	5.0	Normal	2	0.78	0.71	±	2.0	±	1.8
LIQ(Tσ)	Conductivit (temp.)(1°C,v6-head)	±	2.4	Rectangular	√3	0.78	0.71	±	1.1	±	1.0
EPS	Phantom Permittivity	±	14.0	Rectangular	√3	0.25	0.25	±	2.0	±	2.0
VAL	Validation antenna uncertainty	±	5.5	Rectangular	√3	1	1	±	3.2	±	3.2
Pin	Uncertainty in accpted pow er	±	2.5	Normal	2	1	1	±	1.3	±	1.3
DIS	Distance EUT-TSL (VAL) (liqant:10mm)	±	2.0	Normal	1	2	2	±	4.0	±	4.0
Dxyz	Test Sample (dipole) positioning	±	1.0	Normal	1	1	1	±	1.0	±	1.0
RFdfift	Drift of output pow er (measured, <0.1dB)	±	2.3	Rectangular	√3	1	1	±	1.3	±	1.3
-	Correction to the SAR results										
C(e, o)	Deviation to Target (e',σ:10 %, IEC head)	±	1.9	Normal	1	1	0.84	±	1.9	±	1.6
u(ΔSAR)	Combined standard uncertainty			<u>-</u>			RSS	±	10.8	±	10.7
U	Expand uncertainty (95% confidence interval) (v11r06)									±	21.4

This uncertainty budget is suggested by IEC/IEEE 62209-1528 and determined by SPEAG, DASY8 Module SAR Manual, 2024-05 (Chapter 6.2, DASY8 Uncertainty Budget for System Verification, Frequency band: 300 MHz - 6 GHz range). All listed error components have veff equal to oc.

Table of uncertainties are listed for ISO/IEC 17025.

Although this standard determines only the limit value of uncertainty, there is no applicable rule of uncertainty in this. Therefore, the results are derived depending on whether or not laboratory uncertainty is applied.

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Appendix 3-4: Calibration certificates

LIMS ID	Description	Type/Model	Serial Number	Manufacture	Calibration Certificate	Note
146235	Dosimetric E-Field Probe	EX3DV4	3907	SPEAG		-
145090	Dipole Antenna (2.45 GHz)	D2450V2	822	SPEAG		*1
230872	RF Power Source	POWERSORCE1	4300	SPEAG	(-

^{*1:} As stated on page 2 of the certificate, the calibration was performed in accordance with the latest standard IEC/IEEE 62209-1528. Therefore, the reported SAR values are valid for any system that complies with IEC/IEEE 62209-1528 including all new versions of DASY such as DASY6 and DASY8.

-End of report-